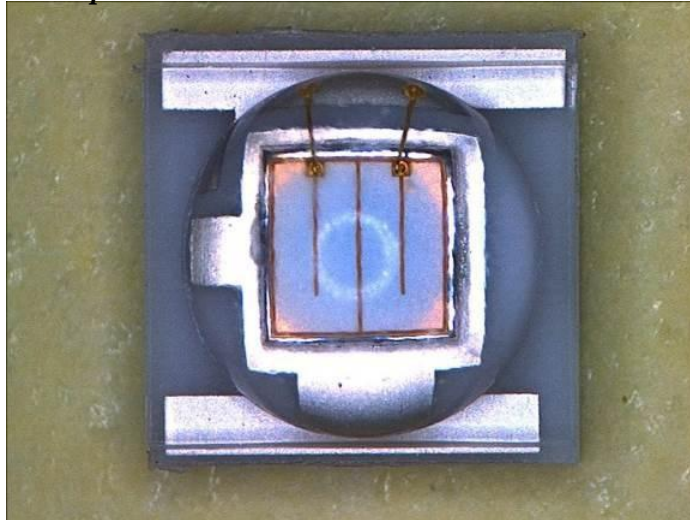




HELIO Optoelectronics Corp.



Helixeon 3535 – UV

Helixeon 3535, a high compact and surface mounted solid-state lighting device, provides high radiometric power output with high optical efficiency. The reduced packing size remarkably promotes the flexibility on engineering design. With capability on standard lead free solder reflow process, Helixeon 3535 is applied for counterfeit currency, defect detection, medical treatment and etc.

Features

- ☐ High compact size for more application flexibility
- ☐ RoHS certification
- ☐

Applications

- ☐ Counterfeit currency
- ☐ Defect detection
- ☐ Medical treatment
- ☐ Party lighting

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Product Nomenclature

XPE **UVA** - **L1**
X1 X2 X3

X1		X2		X3	
Series		Color		Sepcification	
Code	Type	Code	Type	Code	Type
XPE	XP-E	UVA	Ultraviolet 360-410nm	L1	Lambertian

Absolute Maximum Ratings

Parameters	Symbol	Rating	Unit
Continuous Forward current	IF	700	mA
Reverse voltage	VR	Not designed to driven in reverse bias $VR \leq 5$	V
Operating temperature	Topr	-30 ~ 80	°C
LED Storage temperature	Tstgl	-40 ~ 100	°C
Soldering Temperature	Tsolder	260	°C
LED Junction temperature	Tj	120	°C

Note:

1. Proper current derating must be observed to maintain junction temperature below the maximum.

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Characteristics of Helixeon 3535 UV Series

Characteristics at $I_f = 350\text{mA}$ ($T_a = 25^\circ\text{C}$):

Parameter	Symbol	Value			Unit
		Min	Typical	Max	
Radiometric power ⁽¹⁾	P_o	275	500	--	mW
Peak wavelength ⁽³⁾	λ_p	365	---	410	nm
View angle	$2\Theta_{1/2}$	--	125	--	degree
Forward voltage ⁽⁴⁾	V_F	3.2	--	4.2	V

Note:

1. The typical radiometric power of Helixeon will be upgraded per season.
2. Minimum radiometric power performance guaranteed within published operating conditions.
HELIO maintains a tolerance of $\pm 10\%$ on radiometric power measurements.
3. HELIO maintains a tolerance of ± 1 nm for peak wavelength measurement.
4. HELIO maintains a tolerance of ± 0.2 V on forward voltage measurement.



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□ Product Binning

Helixeon emitters are labeled using 6-digit alphanumeric bin code. The formats are explained as follows:

AB CD EF

Where:

AB - designates radiometric power bin.

CD - designates peak wavelength bin.

EF - designates forward voltage bin.

Radiometric power binning information (AB)

Bin Code	Min.	Max.	Unit
AN	210	240	mW
AO	240	285	
AP	285	325	
AQ	325	380	
AR	380	440	
AS	440	520	
AT	520	600	
AU	600	700	
AV	700	800	

Peak wavelength binning information (CD)

Bin Code	Min.	Max.	Unit
VE	360	362.5	nm
CF	362.5	365	
CG	365	367.5	
VH	367.5	370	
VI	370	372.5	
VJ	372.5	375	
VK	375	377.5	
VL	377.5	380	
VM	380	382.5	
VN	382.5	385	
VO	385	387.5	

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Doc.No : DS-144-14-03

VP	387.5	390	
VQ	390	392.5	
VR	392.5	395	
VS	395	397.5	
VT	397.5	400	
EA	400	402.5	
EB	402.5	405	
EC	405	407.5	
ED	407.5	410	

Forward voltage binning information (EF)

Bin Code	Min.	Max.	Unit
8	2.8	3	V
9	3	3.2	
A	3.2	3.4	
B	3.4	3.6	
C	3.6	3.8	

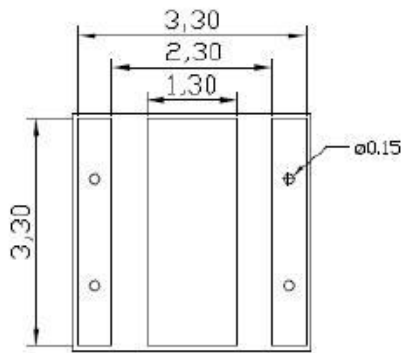
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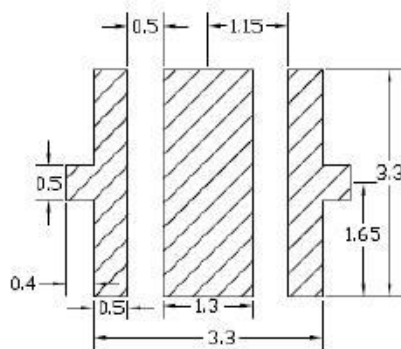
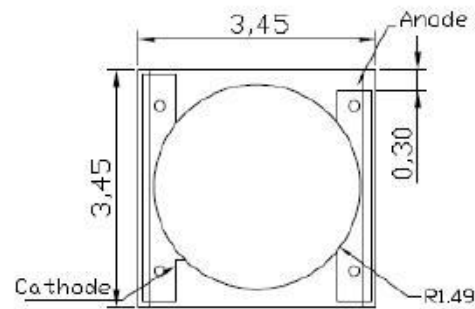
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Mechanical Dimensions

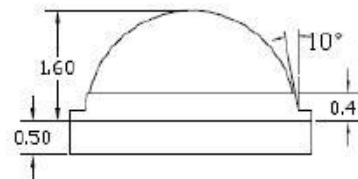
XPE UVA-L1



Bottom Layout

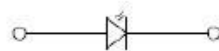


Recommended Solder Pad



Dimension

Anode(+) Cathode(-)



Circuit Diagram

Note:

1. Drawing is not to scale.
2. All dimensions are in millimeter.
3. Dimensions are $\pm 0.13\text{mm}$ unless otherwise indicated.

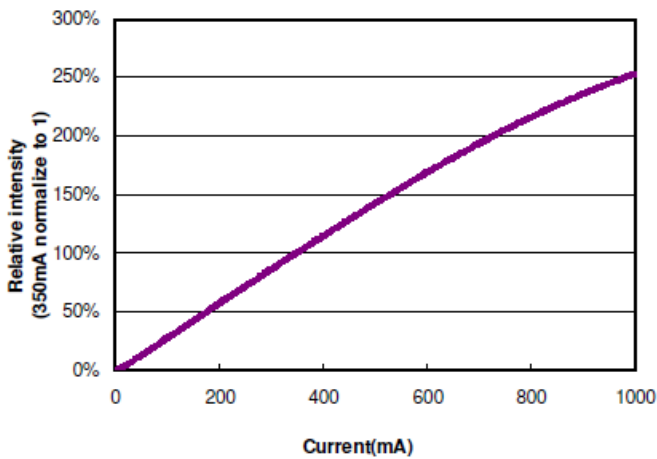
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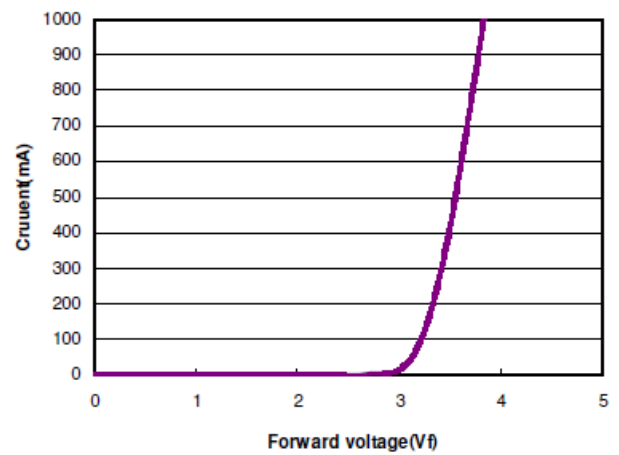
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Electrical & Optical characteristics

Luminous flux (Φ_e) vs Current(I_F)

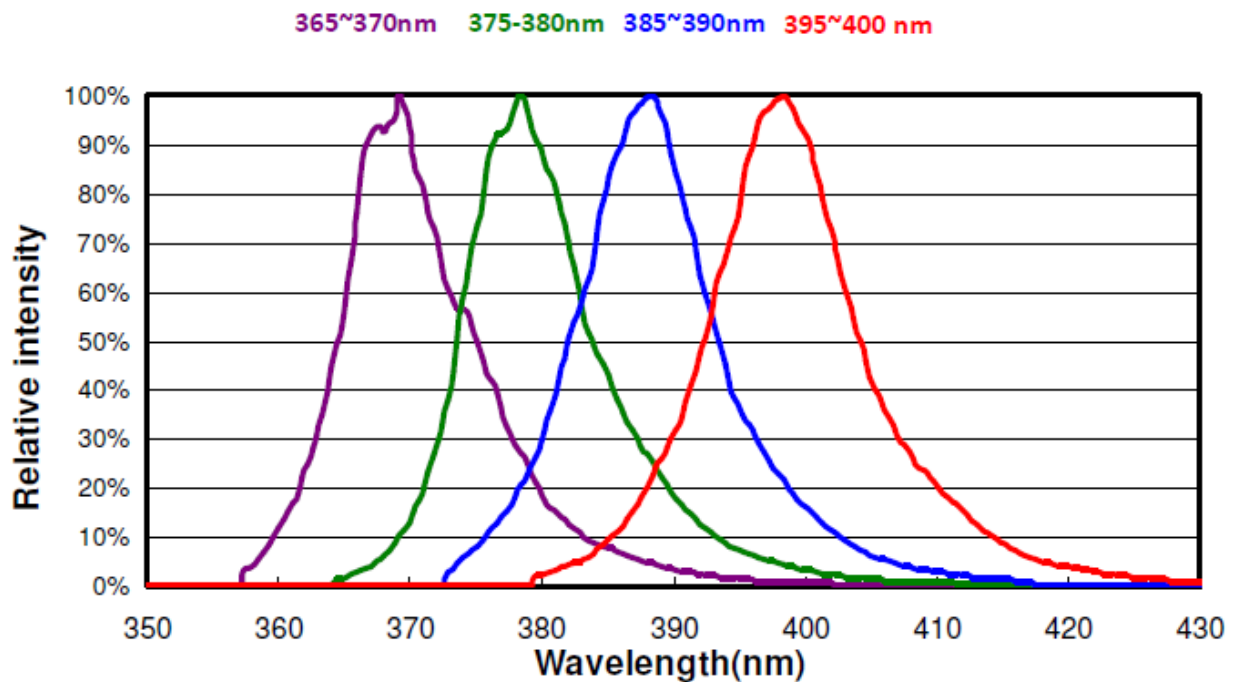


Current(I_F) vs Voltage(V_F)



Emission spectrum

Ultraviolet (365-400 nm) Spectrum Distribution



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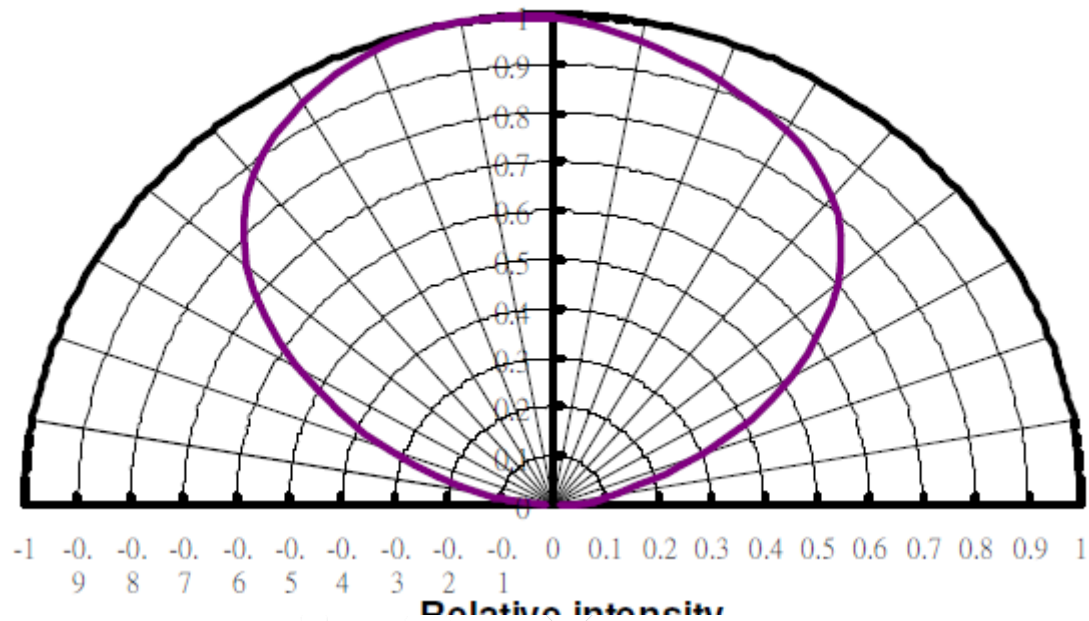


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Radiation Pattern

XPE XXX-L1

Spatial radiation pattern



□ Label

海立爾股份有限公司	
品號: XXXX-XXXX	單號:
品名: XXXXXX-XX	QC
數量: 500 PCS	
Bin Code: XXXXX	
日期: XXXX-XX-XX	

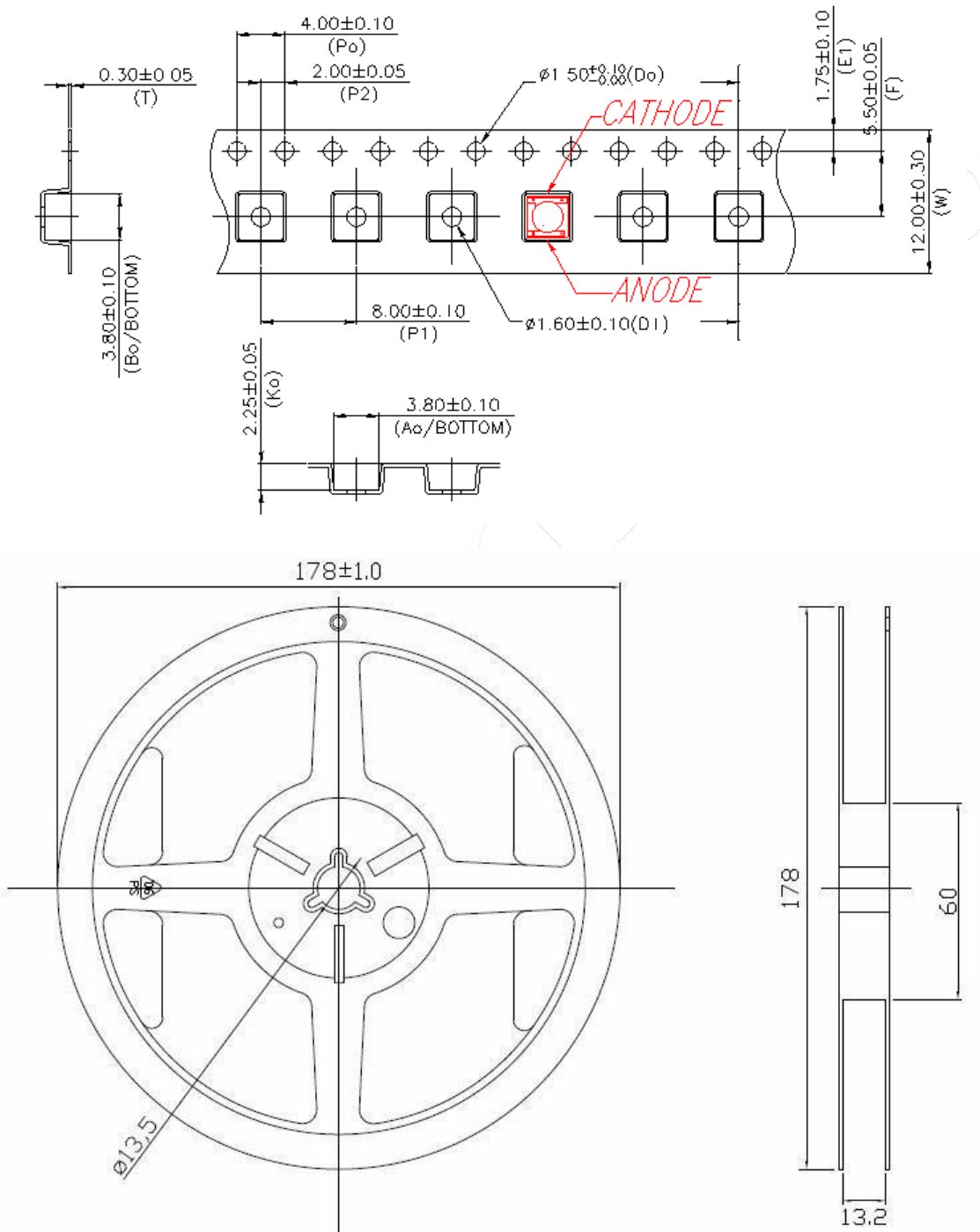
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□ Package Specifications

Tape and Reel

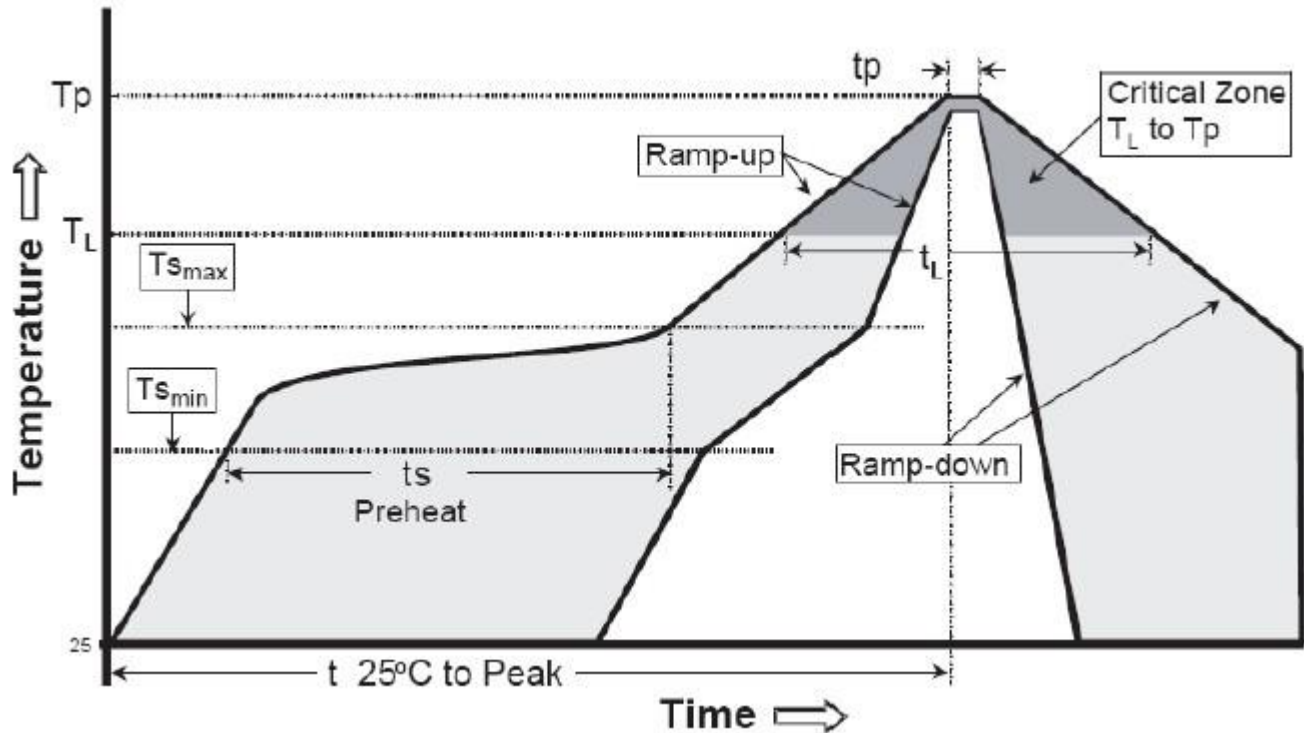


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Reflow soldering conditions



Profile Feature	Typical parameters
Average Ramp-Up Rate ($T_{s_{max}}$ to T_p)	3 °C/second max.
Preheat Temperature Min ($T_{s_{min}}$)	150 °C
Preheat Temperature Max ($T_{s_{max}}$)	200 °C
Time ($T_{s_{min}}$ to $T_{s_{max}}$)	60-180 seconds
Time maintained above Temperature (T_L)	217 °C
Time maintained above Time (T_L)	60-150 seconds
Peak/Classification Temperature (T_p)	240 °C
Time within 5 °C of Actual Peak Temperature (T_p)	5 seconds
Ramp-Down Rate	6 °C/second max.
Time 25 °C to Peak Temperature	8 minutes max.

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